# Notice of References Cited Application/Control No. 10/564,718 Examiner NED A. WALKER Applicant(s)/Patent Under Reexamination ANRAKU ET AL. Page 1 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,416,661 A	11-1983	Norman et al.	604/86
*	В	US-4,664,274 A	05-1987	Konrad, Franz	215/232
*	С	US-4,747,839 A	05-1988	Tarello et al.	604/240
*	D	US-5,100,010 A	03-1992	Waters, William E.	215/248
*	Е	US-5,219,083 A	06-1993	Liebert et al.	215/247
*	F	US-5,370,252 A	12-1994	Parsons et al.	215/247
*	G	US-5,433,330 A	07-1995	Yatsko et al.	215/247
*	Ι	US-5,738,233 A	04-1998	Burns, James A.	215/247
*	I	US-2001/0039058 A1	11-2001	Iheme et al.	436/180
*	J	US-2001/0041336 A1	11-2001	Anderson et al.	435/6
*	K	US-2003/0029828 A1	02-2003	Amschlinger et al.	215/247
*	L	US-2003/0207463 A1	11-2003	Iheme et al.	436/180
*	М	US-6,716,396 B1	04-2004	Anderson et al.	422/99

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	S					
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Matweb by Automation Creations, Inc. "Deflection Temperature Testing of Plastics – Typical Deflection Temperatures and Melting Points of Polymers", Archive dated June 5, 2002, retrieved Feb. 10, 2009 using Archive.org.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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Notice of References Cited	10/564,718	Reexamination ANRAKU ET AL.		
	Application/Control No.	Applicant(s)/Pater	nt Under	

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,723,289 B2	04-2004	Iheme et al.	422/100
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
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# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.